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(PTO-1449)					FILING DATE GRO October 31, 2003			UP		
				U.S. PATEN	T DOCUMENTS					
EXAMINER'S INITIALS	CITE NO.	Num	Document Number liber-Kind Codez (# known)	Publication Date MM-DD-YYYY	Name of Patentee or Appli Document	cant of Cited		Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear		
BIW		US 5,649,213		07/15/1997	Kurihara, et al.					_
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EXAMINER'S	7	Foreign Patent Document Publication Date				Name of Patentee or Pages, Colum		ns. Translation		
INITIALS	CITE NO.	Country Codes -Number 4 -Kind Codes (if known)		MM-DD-YYYY	Applicant of Cited Document	Lines Where Relevant Figures Appear				
	<u> </u>							Yes	No	
BTM			JP 8-50523 A	02/20/1996	SUN MICROSYST INC.			JAPAN (w/English Abstract)		
			JP 9-44278 A	02/14/1997				JAPAN ONLY		
Btm			JP 1-255909 A	10/12/1989	OKI ELECTRIC IND CO LTD			JAPAN (w/English Abstract)		
BTM										
EVALUEDIO	1	1			r, Title, Date, Pertinent Pages, E	- · · · · · · · · · · · · · · · · · · ·	15 - 15 -			
EXAMINER'S INITIALS	CITE NO.	journ), title of the article (when appropers), volume-issue number(s), p				9,	
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